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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/711,414	09/17/2004	Yun-Ren Wang	NAUP0594USA	5413
27765 7590 06/29/2007 NORTH AMERICA INTELLECTUAL PROPERTY CORPORATION		EXAM	INER	
P.O. BOX 506	10/711,414 09/17/2004 Yun-Ren Wang	MILLER, MICHAEL G		
MERRIFIELD, VA 22116			ART UNIT	PAPER NUMBER
			1709	
			NOTIFICATION DATE	DELIVERY MODE
			06/29/2007	ELECTRONIC

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail address(es):

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		Application No.	Applicant(s)		
٠		10/711,414	WANG ET AL.		
Office Action Summary		Examiner	Art Unit		
		Michael G. Miller MGM	1709		
	- The MAILING DATE of this communication app				
Period for					
WHICI - Extens after S - If NO p - Failure Any re	PRTENED STATUTORY PERIOD FOR REPLY HEVER IS LONGER, FROM THE MAILING DOWNS is ions of time may be available under the provisions of 37 CFR 1.1. BIX (6) MONTHS from the mailing date of this communication. Period for reply is specified above, the maximum statutory period was to reply within the set or extended period for reply will, by statute the ply received by the Office later than three months after the mailing dipatent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATIO 36(a). In no event, however, may a reply be ti vill apply and will expire SIX (6) MONTHS fron , cause the application to become ABANDON	N. imely filed in the mailing date of this communication. ED (35 U.S.C. § 133).		
Status					
1)⊠ I	Responsive to communication(s) filed on <u>01 Ju</u>	<u>une 2007</u> .			
2a) <u></u> □	☐ This action is <b>FINAL</b> . 2b) ☑ This action is non-final.				
3) 🗌 🦇	Since this application is in condition for allowar	nce except for formal matters, pr	osecution as to the merits is		
(	closed in accordance with the practice under E	Ex parte Quayle, 1935 C.D. 11, 4	53 O.G. 213.		
Dispositio	on of Claims				
4)⊠ (	Claim(s) <u>1-15</u> is/are pending in the application.				
	a) Of the above claim(s) <u>10-15</u> is/are withdraw				
·	Claim(s) is/are allowed.				
· · ·	Claim(s) <u>1-9</u> is/are rejected.	•			
7) 🗌 (	Claim(s) is/are objected to.				
8) 🗌 (	Claim(s) are subject to restriction and/or	r election requirement.	•		
Applicatio	on Papers				
	he specification is objected to by the Examine	r			
-	The drawing(s) filed on is/are: a) ☐ acce		Fxaminer		
	Applicant may not request that any objection to the				
	Replacement drawing sheet(s) including the correct	· · · · · · · · · · · · · · · · · · ·	• •		
	he oath or declaration is objected to by the Ex		•		
Priority ur	nder 35 U.S.C. § 119				
	cknowledgment is made of a claim for foreign	priority under 25 LLS C S 110/a	) (d) or (f)		
·	All b) Some * c) None of:	priority under 33 0.3.0. § 119(a	)-(u) or (i).		
,	<ul><li>I.☐ Certified copies of the priority documents</li></ul>	s have been received			
	2. Certified copies of the priority documents		ion No.		
3	B. Copies of the certified copies of the prior	• •	<del></del>		
	application from the International Bureau		<b>.</b>		
* Se	ee the attached detailed Office action for a list	• • • • • • • • • • • • • • • • • • • •	∍d.		
		·			
Attachment(s	c)				
`	of References Cited (PTO-892)	4) Interview Summary	/ (PTO-413)		
2) 🔲 Notice	of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail D	ate		
	ation Disclosure Statement(s) (PTO/SB/08) No(s)/Mail Date <u>23 FEB 2006, 30 MAR 2007</u> .	5) Notice of Informal F	Patent Application		

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### **DETAILED ACTION**

#### Election/Restrictions

- 1) Applicant's election of Claims 1-9 in the reply to Examiner's restriction requirement filed on 1 Jun 2007 is acknowledged. Because applicant did not distinctly and specifically point out the supposed errors in the restriction requirement, the election has been treated as an election without traverse (MPEP § 818.03(a)).
- 2) Claims 10-15 are withdrawn from further consideration pursuant to 37 CFR 1.142(b) as being drawn to a nonelected invention, there being no allowable generic or linking claim. Election was made without traverse in the reply filed on 1 Jun 2007.

## Claim Rejections - 35 USC § 103

- 3) The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4) Claims 1-9 are rejected under 35 U.S.C. 103(a) as being unpatentable over Laxman et al (U.S. Patent 5,976,991, hereinafter '991) in view of Takahashi (U.S. Patent 5,517,943, hereinafter '943) and further in view of Kaizuka et al (U.S. Patent 6,436,203, hereinafter '203).

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- i) With regard to Claim 1, '991 teaches a method for depositing silicon nitride on a substrate, comprising:
  - (1) providing a chemical vapor deposition (CVD) system comprising a tubular furnace (Column 7 Lines 29-37, 58-64), at least one BTBAS (bis t-ButylaminoSilane) supply piping line (Column 7 Lines 58-64) connected to a base portion of said tubular furnace, an exhaust piping line (implicitly taught by the presence of the vacuum pump, Column 7 Lines 43-45) connected to an upper portion of said tubular furnace, a bypass line connecting said BTBAS supply piping line with said exhaust piping line (not explicitly taught), and a vacuum pump (Column 7 Lines 43-45) connected to said exhaust piping line, wherein said bypass line is initially interrupted (not explicitly taught);
  - (2) placing a batch of wafers (Column 7 Lines 47-49) into a tube of said tubular furnace (Column 7 Lines 29-30);
  - (3) flowing nitrogen-containing gas into said tube (Column 8 Lines 57-60);
  - (4) flowing BTBAS into said tube through said BTBAS supply piping line (Column 8 Lines 57-60) and said vacuum pump (Column 7 Lines 42-45) maintaining pressure in said tube in a range of between about 0.1 Torr and 3 Torr (Column 3 Lines 16-17 discuss a range of 0.02 – 760 Torr; Column 8 Lines 57-60 disclose a pressure point of 0.5 Torr);
  - (5) performing a silicon nitride deposition process in said tube to deposit a BTBAS-based silicon nitride film on said wafers (Column 8 Lines 60-63;

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for silicon nitride deposition NH<sub>3</sub> would be the preferred if not sole nitrogen-containing gas);

- (6) upon completion of said silicon nitride deposition process, interrupting said BTBAS supply piping line (see point 9 below) and opening said initially interrupted bypass line (not taught); and
- (7) removing said batch of wafers (see point 9 below).
- (8) '991 does not explicitly teach the vertical locations of the piping and exhaust lines, a bypass line, or that the bypass line starts out interrupted and is later opened.
- (9) It would have been obvious to a person having ordinary skill in the art at the time the invention was made to interrupt the BTBAS supply line at the end of deposition, since terminating the flow of a reactant was a known way to terminate a reaction, and to remove the batch of wafers from the reactor at the end of processing, since it would have been desirable to use the reactor to coat multiple batches of wafers in its lifespan.
- ii) '943 teaches an apparatus for chemical vapor deposition comprising:
  - (1) a tubular furnace (Item 3, Figure 1),
  - (2) at least one BTBAS (bis t-ButylaminoSilane) supply piping line (Items 6-8, Figure 1; taught as generic reaction gas supply lines) connected to a base portion (via Items 4a and 4b connected from Items 15a and 15b, Figure 1) of said tubular furnace,

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- (3) an exhaust piping line (Item 16A, Figure 1) connected to an upper portion of said tubular furnace (via Items 4a and 4b going to Items 16a and 16b, Figure 1),
- (4) a bypass line connecting said BTBAS supply piping line with said exhaust piping line (not explicitly taught),
- (5) and a vacuum pump connected to said exhaust piping line (Item 19, Figure 1),
- (6) wherein said bypass line is initially interrupted (not explicitly taught).
- (7) '943 also teaches a 'flip-flop' gas flow pattern (Column 4 Lines 27-33, Column 5 Lines 7-16) which is advantageous for aiding the uniformity of the deposited coating.
- iii) '203 teaches a bypass mechanism (Column 4 Line 64 Column 5 Line 65) comprising a valve (Item 26, Figure 2) for initiating and terminating the gas supply, a supply line (Item 21, Figure 2) for providing gas to the system, a switch valve (Item 28, Figure 2) for diverting flow between the chamber and the exhaust, a switch valve (Item 29, Figure 2) for controlling the flow of a purge gas, and an exhaust line (Item 36, Figure 2) to connect to the exhaust system (Item 9, Figure 2, not shown explicitly). '203 also teaches that this system is used to exhaust unwanted gas from the entire system (Column 7 Lines 22-29; there is no mention of valve 26 being closed so the system is evacuated all the way to the source). '203 also teaches that this bypass

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- system is designed to prevent mingling of process gasses which may undergo unwanted side reactions (Column 8 Lines 48-63).
- iv) Therefore, it would have been obvious to a person having ordinary skill in the art at the time the invention was made to have modified the apparatus as taught by modifying the apparatus of '943 to include a bypass mechanism connected to the exhaust system as taught in '203 because the bypass mechanism prevents unwanted mixing of gases and prevents reaction of gases to form unwanted products..
- v) Furthermore, it would have been obvious to a person having ordinary skill in the art at the time the invention was made to have performed the method of '991 using the apparatus of '943 as modified by the bypass mechanism of '203 because '991 teaches a method of depositing a silicon nitride film, '943 teaches an apparatus capable of depositing a silicon nitride film, and the apparatus of '943 advantageously improves the uniformity of the deposited film and therefore the quality of the final product.
- vi) With specific regard to Claim 2, which includes all the limitations of Claim 1 above, '943 teaches:
  - (1) Wherein after removing said batch of wafers, the process further comprises flowing cleaning gas into said tube (Column 5 Line 33 – Column 6 Line 38).
- vii) With specific regard to Claim 3, which includes all the limitations of Claim 2 above, '943 teaches:

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(1) Wherein said cleaning gas comprises CIF<sub>3</sub> (Column 8 Lines 1-7).

viii)With specific regard to Claim 4, which includes all the limitations of Claim 2 above, '943 teaches:

- (1) Wherein said cleaning gas comprises NF<sub>3</sub> (Column 8 Lines 1-7).
- ix) With specific regard to Claim 5, which includes all the limitations of Claim 1 above, '203 teaches:
  - (1) Wherein by opening said initially interrupted bypass line upon completion of said silicon nitride deposition process, said BTBAS remaining in said BTBAS supply piping line is evacuated through said bypass line without entering said tubular furnace, thereby eliminating particle problems (Column 8, Lines 48-63, taught with different gas but on identical principle).
- x) With specific regard to Claim 6, which includes all the limitations of Claim 1 above, '991 teaches:
  - (1) Wherein said nitrogen-containing gas comprises ammonia gas (Column 8 Line 57 – Column 9 Line 7).
- xi) With specific regard to Claim 7, which includes all the limitations of Claim 1 above, '991 teaches:
  - (1) Wherein silicon nitride deposition process is carried out at a temperature of between 450-600°C (Column 9 Lines 1-7 explicitly teaches 600°C).
- xii) With specific regard to Claim 8, which includes all the limitations of Claim 1 above, '991 teaches:

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(1) Wherein said BTBAS is flowed into said tube at a flow rate of about 25-500 sccm (Column 8 Lines 60-63 explicitly teach 60 sccm of BTBAS).
xiii)With specific regard to Claim 9, which includes all the limitations of Claim 1 above, '991 teaches:

(1) wherein said nitrogen-containing gas is flowed into said tube at a flow rate of about 50-1000 sccm (Column 8 Lines 64-65 teach a flow of 200 sccm of nitrogen containing gases; as detailed in Figure 2, the composition of the mixture was allowed to vary).

#### **Conclusion**

5) The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. U.S. Patents 6,153,261 and 6,936,548, as well as U.S. PGPub 2004/0096582, teach similar methods of CVD using aminated silane compounds. U.S. PGPubs 2001/0000476 and 2005/0255712 discuss flow rates of similar process gases in CVD processes. U.S. Patent 5,540,777 discusses a similar bypass process.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael G. Miller whose telephone number is (571) 270-1861. The examiner can normally be reached on MTWR 7:30 - 5:00, F 7:30 - 4:00, Eastern Time.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Cleveland can be reached on (571) 272-1418. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

MGM MGM

MICHAEL B. CLEVEZAND